

20V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

 V_{DS} 20V I_{D} (at V_{GS} =10V) 120A

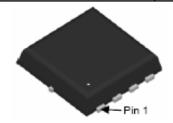
 $R_{DS(ON)}$ (at $V_{GS} = 10V$) < 3.4m Ω

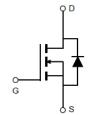
$$\begin{split} R_{DS(ON)} & \text{ (at V}_{GS} \!=\! 4.5 \text{V)} & < 3.8 \text{m} \Omega \\ R_{DS(ON)} & \text{ (at V}_{GS} \!=\! 2.5 \text{V)} & < 5.1 \text{m} \Omega \end{split}$$

100% UIS Tested



DFN3.3x3.3





Part Number	Package Type	Form	Marking	
TTG120N02GT	DFN3.3x3.3	Tape&Reel	120N02GT	

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current B	T _C =25°C	I _D	17	٨
	T _C =100°C		17	A
Pulsed Drain Current A		I _{DM}	360	Α
Avalanche Current A		I _{AS}	26	А
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	101	mJ
Power Dissipation ^C	T _C =25°C	P _D	108	W
	T _C =100°C		54.3	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C

Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	R _{eJC}	1.38	00.00	
Maximum Junction-to-Ambient	Steady-State	R _{OJA}	100	°C/W	



Symbol	Borometer	Conditions		Value			Units
Symbol	Parameter Conditions			Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		20			V
		V _{DS} =20V, V _{GS} =0V	T _J =25°C			1	- μΑ
I _{DSS}	Zero Gate Voltage Drain Current		T _J =100°C			25	
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$				±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		0.5	0.7	1.2	V
		V _{GS} =10V, I _D =30A			2.6	3.4	mΩ
R _{DS(ON)} Static Drain-Source On-Res	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =30A			2.9	3.8	mΩ
		V _{GS} =2.5V, I _D =30A			3.9	5.1	mΩ
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =20A			15		S
V_{SD}	Diode Forward Voltage	I _S =50A, V _{GS} =0V				1	V
I _s	Maximum Body-Diode Continuous Curre	rent ^B				17	А
DYNAMIC	PARAMETERS				-		
C _{iss}	Input Capacitance				4066		
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 10V, f = 1MH_Z$			1107		pF
C _{rss}	Reverse Transfer Capacitance				655		
SWITCHIN	NG PARAMETERS						
Q _g (10V)	Total Gate Charge				118		
Q_{gs}	Gate Source Charge	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A$			7		nC
Q_{gd}	Gate Drain Charge				22		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A,$ $R_{G} = 3\Omega$			12		
t _r	Turn-On Rise Time				11		ns
$T_{D(off)}$	Turn-Off Delay Time				39		
t _f	Turn-Off Fall Time				18		
t _{rr}	Body Diode Reverse Recovery Time	I FOA d:/d+ 4004/			19		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =50A, di/dt =100A/μs			17		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

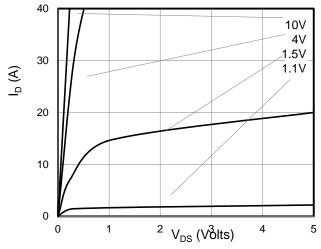


Figure 1: On-Region Characteristics

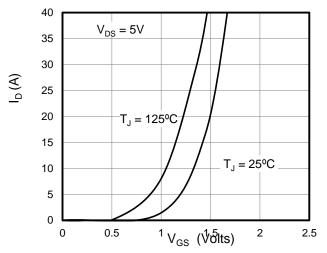


Figure 2: Transfer Characteristics

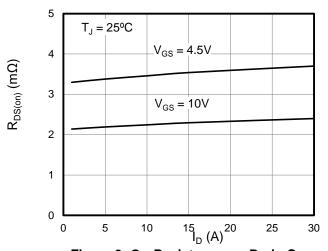


Figure 3: On-Resistance vs. Drain Current

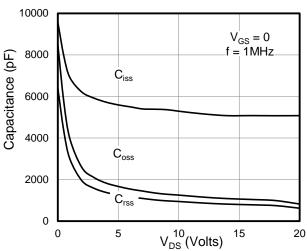


Figure 4: Capacitance Characteristics

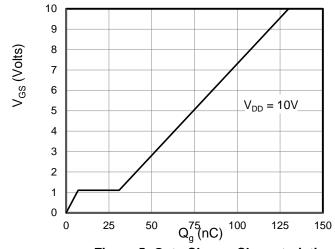


Figure 5: Gate Charge Characteristics

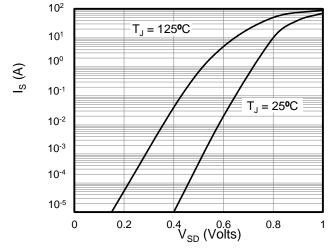


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$ Normalized Transient Thermal Resistance

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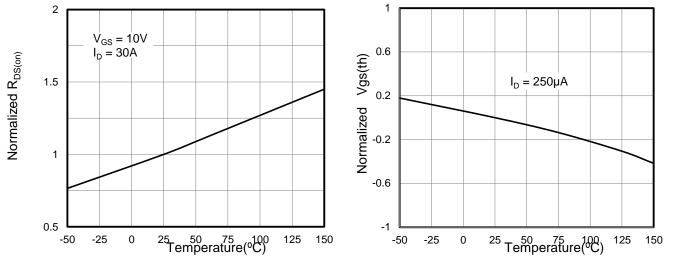


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature

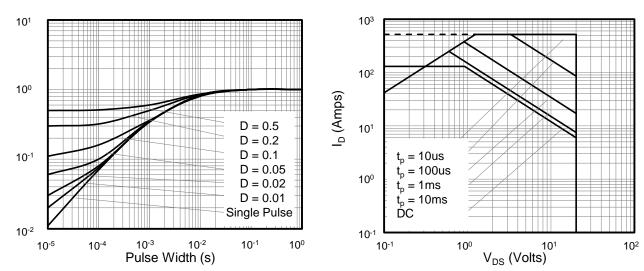


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

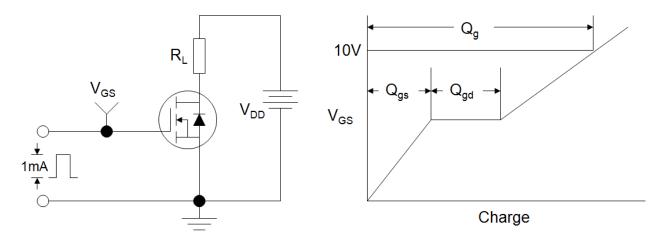


Figure A: Gate Charge Test Circuit and Waveforms

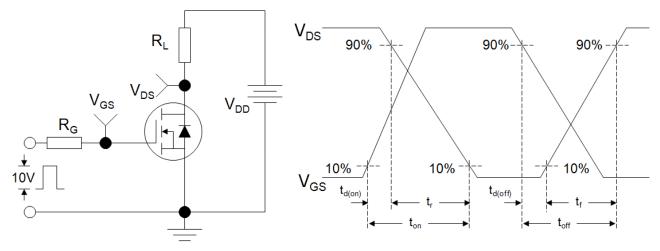


Figure B: Resistive Switching Test Circuit and Waveforms

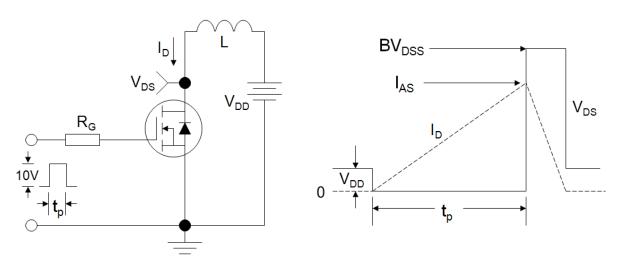
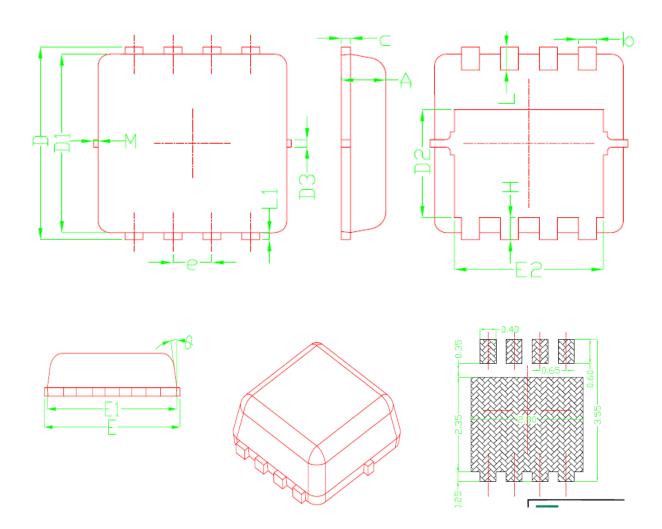


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



DFN 3.3x3.3



# T T T T T T T T T T T T T T T T T T T	DIMENSIONAL REOMTS			
SYMBOL	MIN	NOM	MAX	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
DI	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
D3		0.13		
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
H	0.30	0.39	0.50	
L	0.30	0.40	0.50	
LI		0.13		
θ		10°	12°	
M	*	*	0.15	
* Not specified				



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